STF5N65M6



N-channel 650 V, 1.15 Ω typ., 4 A MDmesh™ M6 Power MOSFET in a TO-220FP package

Datasheet - production data

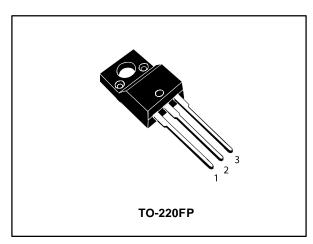
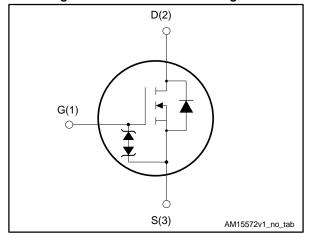


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ΙD
STF5N65M6	650 V	1.3 Ω	4 A

- Reduced switching losses
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

Table 1: Device summary

Order code	Marking	Package	Packing
STF5N65M6	5N65M6	TO-220FP	Tube

Contents STF5N65M6

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STF5N65M6 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _G s	Gate-source voltage	± 25	V
I _D	Drain current (continuous) at T _C = 25 °C	4	Α
ΙD	Drain current (continuous) at T _C = 100 °C	2.5	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	16	Α
P _{TOT}	Total dissipation at T _C = 25 °C	20	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	5	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/IIS
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s, T_C = 25 °C)	2.5	kV
TJ	Operating junction temperature range	FF to 150	°C
T _{stg}	Storage temperature range	-55 to 150	

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	6.25	°C/W
R _{thj-amb}	Thermal resistance junction-ambient		*C/VV

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax})	1	Α
Eas	Single pulse avalanche energy (starting T_j =25°C, I_D = I_{AR} , V_{DD} =50 V)	90	mJ

⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \leq 4$ A, di/dt = 400 A/ μ s; VDS peak < V(BR)DSS, VDD = 400 V

 $^{^{(3)}}V_{DS} \le 520 \text{ V}$

Electrical characteristics STF5N65M6

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS}=0$, $I_D=1$ mA	650			V
		V _{GS} = 0 V, V _{DS} = 650 V			1	μΑ
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V};$ $T_{C} = 125 \text{ °C}^{(1)}$			100	μΑ
Igss	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±5	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2.25	3	3.75	V
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 2 \text{ A}$		1.15	1.3	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	170	•	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	20	ı	pF
C _{rss}	Reverse transfer capacitance	755 = 166 V, 1 = 1 Mile, V66 = 6 V	-	1	ı	pF
Coss	Equivalent output capacitance	V _{DS} = 0 to 520 V, V _{GS} = 0 V	-	35	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I _D =0 A	1	5	ı	Ω
Qg	Total gate charge	V _{DD} = 350 V, I _D = 1 A, V _{GS} = 10 V,	-	5.1	•	nC
Qgs	Gate-source charge	(see Figure 15: "Test circuit for	-	8.0	ı	nC
Q_{gd}	Gate-drain charge	gate charge behavior")	-	2	1	nC

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V_{DD} = 325 V, I_D = 2 A, R_G = 4.7 Ω ,	ı	6.5	-	ns
t _r	Rise time	V _{GS} = 10 V (see Figure 14: "Test circuit for resistive load switching	-	5.9	-	ns
t _{d(off)}	Turn-off delay time	times" and Figure 19: "Switching	-	17.4	-	ns
t _f	Fall time	time waveform")	-	15.2	-	ns

 $^{^{(1)}}$ Defined by design, not subject to production test.

 $^{^{(1)}}$ Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		ı		4	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		ı		16	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 4 A, V _{GS} = 0 V			1.6	٧
t _{rr}	Reverse recovery time	I _{SD} = 4 A, di/dt = 100 A/µs,	-	222		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V, (see <i>Figure 19</i> :	ı	1.24		μC
I _{RRM}	Reverse recovery current	"Switching time waveform")	-	11.2		Α
t _{rr}	Reverse recovery time	I _{SD} = 4 A, di/dt = 100 A/μs,	-	264		ns
Qrr	Reverse recovery charge $V_{DD} = 60 \text{ V}, T_j = 150 \text{ °C}$ (see Figure 19: "Switching		-	1.39		μC
I _{RRM}	Reverse recovery current	time waveform")	-	10.5		Α

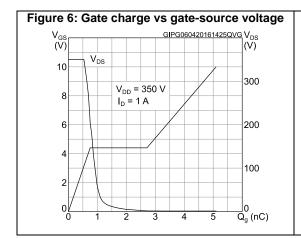
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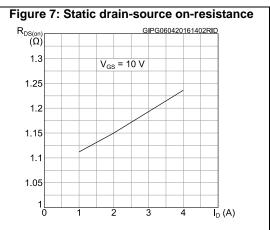
⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2: Safe operating area GIPG060420161432SOA (A) Operation in this area is limited by R_{DS(on)} 10 t_⊳=10 µs 10⁰ t₀=100 µs t =1 ms t_o=10 ms 10 T_j≤150 °C T_o= 25°C single pulse 10⁻² $\bar{V}_{DS}(V)$ 10¹ 10²





STF5N65M6 Electrical characteristics

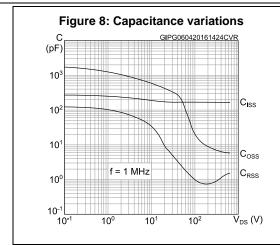


Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG060420161401RON

2.2 V_{GS} = 10 V

1.8

1.4

1.0

0.6

0.2

-75

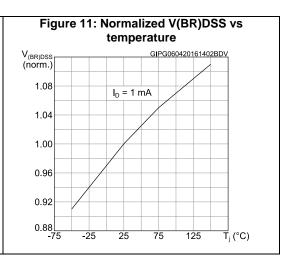
-25

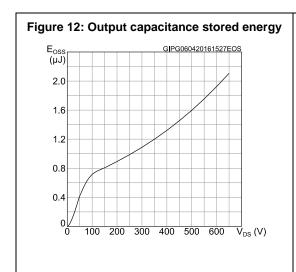
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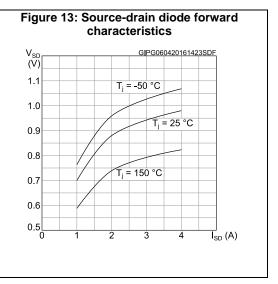
75

125

T_j (°C)







Test circuits STF5N65M6

3 Test circuits

Figure 14: Test circuit for resistive load

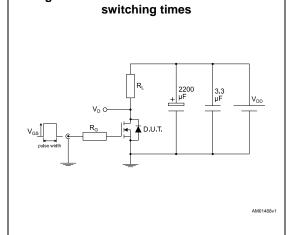


Figure 15: Test circuit for gate charge behavior

12 V 47 KΩ 100 Ω D.U.T.

12 V 47 KΩ VGD

14 VGD

15 VGD

16 CONST 100 Ω D.U.T.

16 CONST 100 Ω VGD

AM01469v1

Figure 16: Test circuit for inductive load switching and diode recovery times

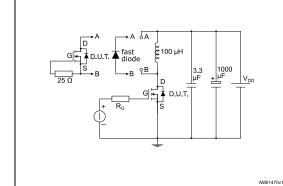


Figure 17: Unclamped inductive load test circuit

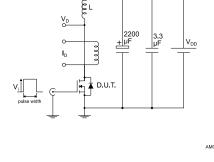


Figure 18: Unclamped inductive waveform

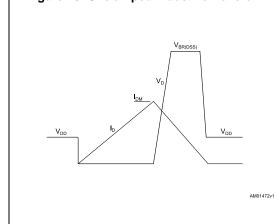
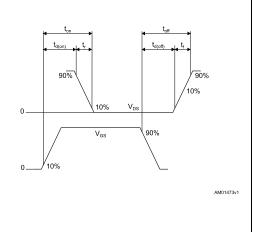


Figure 19: Switching time waveform



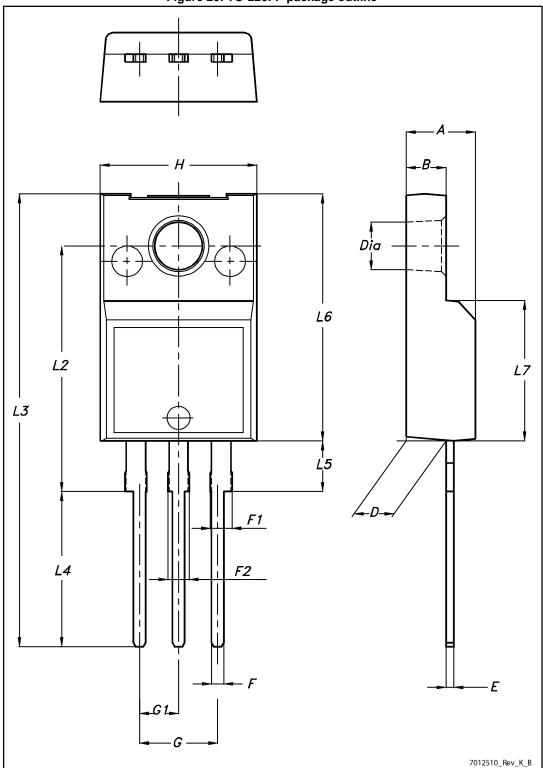
STF5N65M6 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-220FP package information

Figure 20: TO-220FP package outline



STF5N65M6

Table 9: TO-220FP package mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	4.4		4.6
В	2.5		2.7
D	2.5		2.75
Е	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

Revision history STF5N65M6

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
05-May-2016	1	Initial release.

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